

SECOND

LIST OF REFERENCES CITED BY
APPLICANT

(REVISED FORM PTO-1449)

DATED: July 24, 2002

Applicant: Masanori MOCHIZUKI

U.S. Filing Date:
November 2, 2001Art Unit:
3724

U. S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	Cl.	Sub- Cl.	Fil. Date
AB	3 3 4 7 6 0 3	10/1967	Ignatjev	-	-	-
AC	3 6 2 2 2 1 1	11/1971	Mitton	-	-	-
AD	3 8 5 9 0 0 3	01/1975	Schulz et al.	-	-	-
AE	4 3 4 6 9 4 5	08/1982	Tsuboi	-	-	-
AF	5 1 6 1 9 2 6	11/1992	Schulz	-	-	-

FOREIGN PATENT DOCUMENTS

DOCUMENT NO.	DATE	COUNTRY	Cl.	Sub- Cl.	Trans.	
					Yes	No
AG 0 9 2 4 0 2 5	06/1999	Europe	-	-	x	
AH 11 1 8 2 5 4 5	07/1999	Japan	-	-	=AG	

OTHER DOCUMENTS

EXAMINER

DATE CONSIDERED

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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Sheet <u>1</u> of <u>1</u>				Atty. Docket No. 4272		Serial No.: 10/053,221			
LIST OF REFERENCES CITED BY APPLICANT (REVISED FORM PTO-1449) DATED <u>March 8, 2002</u>				Applicant: Masanori MOCHIZUKI					
				U.S. Filing Date: November 2, 2001		Art Unit: 3724			
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		DOCUMENT NO.		DATE	COUNTRY	Cl.	Sub- Cl.	Trans.	
								Yes	No
AA		3 - 8 1 0 3 5		04/1991	Japan	-	-		x
OTHER DOCUMENTS									
EXAMINER					DATE CONSIDERED				
<i>[Signature]</i>					1-20-04				
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